

Search Notes

Application/Control No.

10/679,000

Examiner

Sheng-Jen Tsai

Applicant(s)/Patent under
Reexamination

CHANG ET AL.

Art Unit

2186

SEARCHED

Class	Subclass	Date	Examiner
714	763	6/19/2006	SJT
711	103	6/19/2006	SJT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East: "ECC" with "flash" "NAND flash memory" "MLC NAND flash memory" "hamming code"	6/19/2006	SJT